



Twin Build in Biasing Circuit MOS FET IC VHF/VHF RF Amplifier



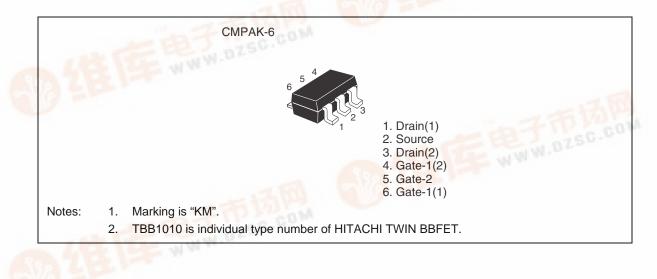
ADE-208-1607B (Z)

3rd. Edition Feb. 2003

Features

- Small SMD package CMPAK-6 built in twin BBFET; To reduce using parts cost & PC board space.
- High $|yfs|=29mS \times 2$
- Suitable for World Standard Tuner RF amplifier.
- Very useful for total tuner cost reduction.
- Withstanding to ESD; Build in ESD absorbing diode. Withstand up to 200 V at C = 200 pF, Rs = 0 conditions.
- Provide mini mold packages; CMPAK-6

Outline





Absolute Maximum Ratings

 $(Ta = 25^{\circ}C)$

Item	Symbol	Ratings	Unit	
Drain to source voltage	V _{DS}	6	V	
Gate1 to source voltage	V _{G1S}	+6 -0	V	
Gate2 to source voltage	V _{G2S}	+6 -0	V	
Drain current	Ι _D	30	mA	
Channel power dissipation	Pch ^{*3}	250	mW	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

Notes: 3. Value on the glass epoxy board ($50mm \times 40mm \times 1mm$).



Electrical Characteristics

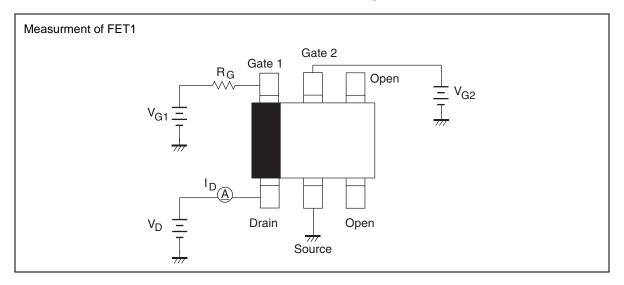
 $(Ta = 25^{\circ}C)$

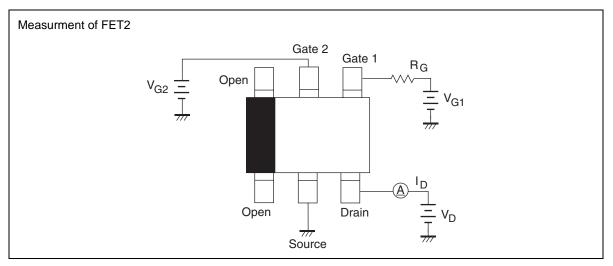
The below specification are applicable for FET1 and FET2 unit

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	6	_	_	V	$I_D = 200 \ \mu\text{A}, \ V_{G1S} = V_{G2S} = 0$
Gate1 to source breakdown voltage	V _{(BR)G1SS}	+6	_	_	V	I_{G1} = +10 μ A, V_{G2S} = V_{DS} = 0
Gate2 to source breakdown voltage	V _{(BR)G2SS}	+6	_	_	V	I_{G2} = +10 μ A, V_{G1S} = V_{DS} = 0
Gate1 to source cutoff current	I _{G1SS}		—	+100	nA	V_{G1S} = +5 V, V_{G2S} = V_{DS} = 0
Gate2 to source cutoff current	I _{G2SS}		_	+100	nA	V_{G2S} = +5 V, V_{G1S} = V_{DS} = 0
Gate1 to source cutoff voltage	$V_{G1S(off)}$	0.6	_	1.1	V	$V_{DS} = 5 V, V_{G2S} = 4 V,$ $I_D = 100 \mu A$
Gate2 to source cutoff voltage	$V_{\text{G2S(off)}}$	0.6	_	1.1	V	$V_{DS} = 5 V, V_{G1S} = 5 V,$ $I_D = 100 \mu A$
Drain current	I _{D(op)}	12	16	20	mA	
Forward transfer admittance	y _{fs}	24	29	_	mS	
Input capacitance	Ciss	1.7	2.1	2.5	pF	$V_{DS} = 5 V, V_{G1} = 5 V$
Output capacitance	Coss	1.0	1.4	1.8	pF	V_{G2S} =4 V, R _G = 120 kΩ
Reverse transfer capacitance	Crss	—	0.03	0.05	pF	f = 1 MHz
Power gain	PG	25	30	_	dB	$V_{DS} = V_{G1} = 5 V, V_{G2S} = 4 V$
Noise figure	NF	_	1.1	1.8	dB	R_G = 120 k Ω , f = 200 MHz

Test Circuits

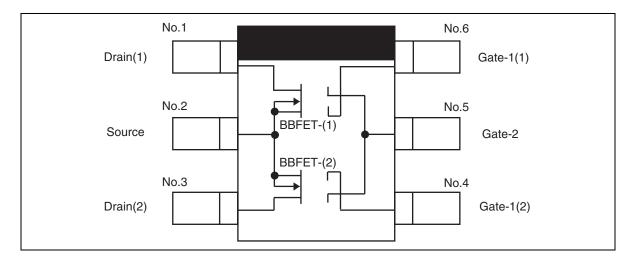
• DC Biasing Circuit for Operating Characteristic Items (I_{D(op)}, |yfs|, Ciss, Coss, Crss, NF, PG)



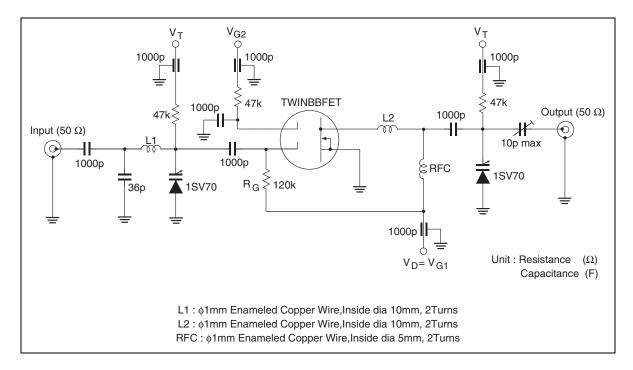




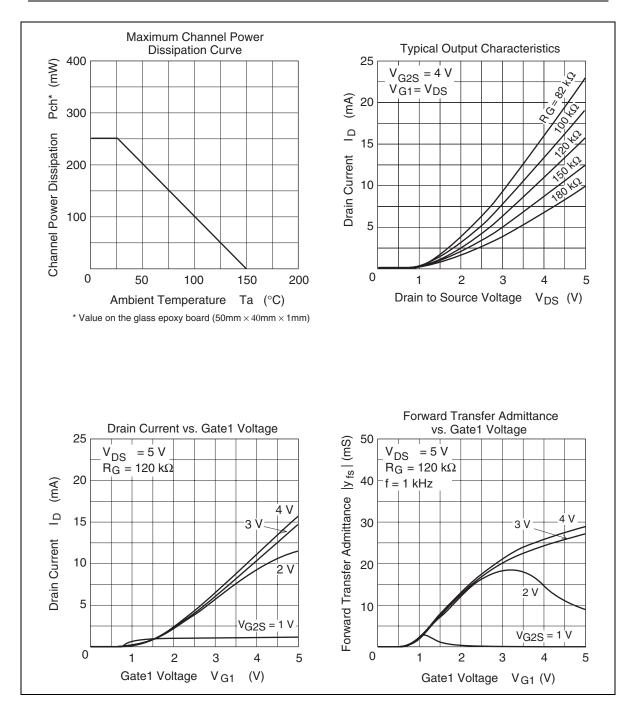
• Equivalent Circuit



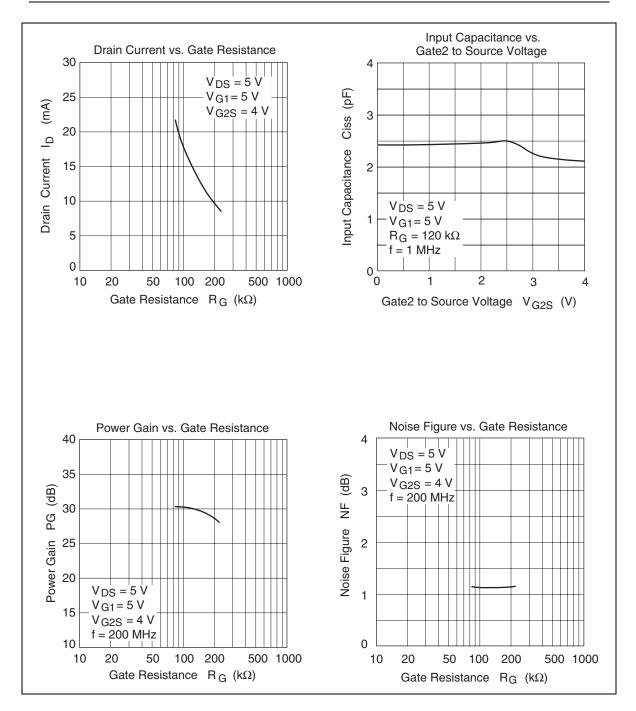
• 200 MHz Power Gain, Noise Figure Test Circuit



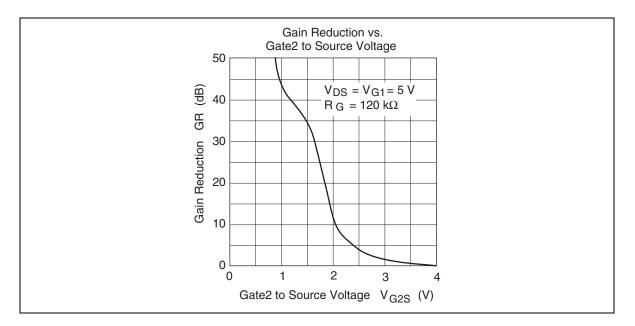
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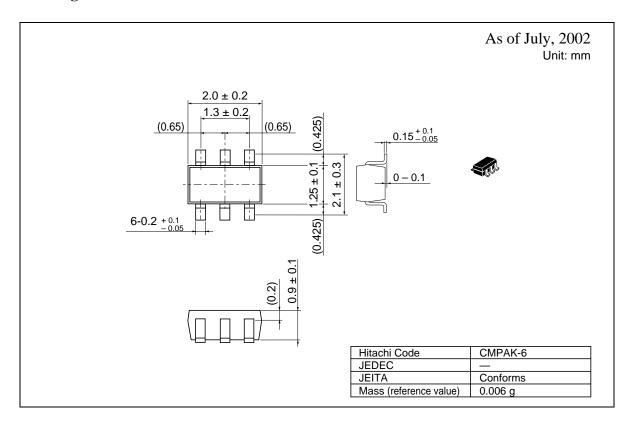


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Package Dimensions





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